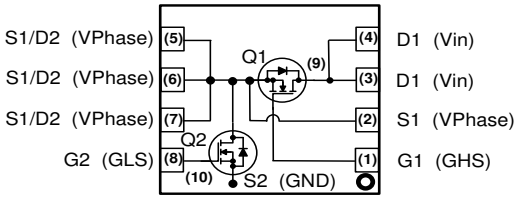
Power Block

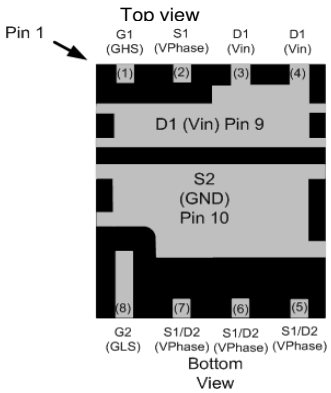
Features

- Dual asymmetric N-channel OptiMOS™5 MOSFET
- Logic level (4.5V rated)
- Optimized for high performance buck converters
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC[1] for target applications
- Halogen-free according to IEC61249-2-21
- Monolithic integrated Schottky like diode

Product Summary

		Q1	Q2	
V_{DS}		25	25	V
$R_{DS(on),max}$	V_{GS}=10 V	3	1.2	mΩ
	V_{GS}=4.5 V	4	1.7	
I_D		50	50	A





Pb-Free RoHS Halogen-Free

Type	Package	Marking
BSG0813NDI	PG-TISON8-4	0813NDI

Maximum ratings, at Tj=25°C, unless otherwise specified [2]

Parameter	Symbol	Conditions	Value		Unit
			Q1	Q2	
Continuous drain current	I_D	T_C=70 °C, V_{GS}=10 V	50	50	A
		T_C=70 °C, V_{GS}=4.5 V	50	50	
		T_A=25 °C, V_{GS}=4.5 V[3]	31	50	
		T_A=25 °C, V_{GS}=4.5 V[4]	19	33	
Pulsed drain current	$I_{D,pulse}$	T_C=70 °C	160	160	
Avalanche energy, single pulse	E_{AS}	Q1: I_D=10 A, Q2: I_D=20 A, R_{GS}=25 Ω	30	90	mJ
Gate source voltage	V_{GS}	T_j=25 °C	±16		V
Power dissipation	P_{tot}	T_A=25 °C[3]	6.25	6.25	W
		T_A=25 °C[4]	2.5	2.5	
Operating and storage temperature	T_j, T_{stg}		-55 ... 150		°C
IEC climatic category; DIN IEC 68-1			55/150/56		

[1] J-STD20 and JESD22

Parameter		Symbol	Conditions	Values			Unit
				min.	typ.	max.	
Thermal characteristics							
Thermal resistance, junction - case	Q1	R_{thJC}		-	-	4.3	K/W
	Q2			-	-	2.2	
Thermal resistance, junction - ambient[2]	Q1	R_{thJA}	Application specific board[3]	-	-	20	
	Q2						
	Q1		6 cm^2 cooling area[4]	-	-	50	
	Q2						
Electrical characteristics, at T_j=25 °C, unless otherwise specified							
Static characteristics							
Drain-source breakdown voltage	Q1	$V_{(BR)DSS}$	V_{GS}=0 V, I_D=1 mA	25[6]	-	-	V
	Q2						
Breakdown voltage temperature coefficient	Q1	$dV_{(BR)DSS}/dT_j$	I_D=10 mA, referenced to 25 °C	-	15	-	mV/K
	Q2						
Gate threshold voltage	Q1	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=250 µA	1.2	1.6	2	V
	Q2						
Zero gate voltage drain current	Q1	I_{DSS}	V_{DS}=25 V, V_{GS}=0 V, T_j=25 °C	-	-	1	µA
	Q2			-	-	500	
	Q1		V_{DS}=20 V, V_{GS}=0 V, T_j=125 °C	-	-	100	
	Q2			-	1	-	mA
Gate-source leakage current	Q1	I_{GSS}	V_{GS}=16 V, V_{DS}=0 V	-	-	100	nA
	Q2						
Drain-source on-state resistance	Q1	$R_{DS(on)}$	V_{GS}=4.5 V, I_D=20 A	-	3.2	4.0	mΩ
	Q2			-	1.2	1.7	
	Q1		V_{GS}=10 V, I_D=20 A	-	2.4	3.0	
	Q2			-	0.9	1.2	
Gate resistance	Q1	R_G		-	0.7	1.2	Ω
	Q2			-	1	1.7	
Transconductance	Q1	g_{fs}	$\|V_{DS}\|>2\|I_D\|R_{DS(on)max}$, I_D=20 A	46	93	-	S
	Q2			70	140	-	

[2] Only one of both transistors active

Parameter		Symbol	Conditions	Values			Unit
				min.	typ.	max.	
Dynamic characteristics							
Input capacitance	Q1	C_{iss}	V_{GS}=0 V, V_{DS}= 12 V, f=1 MHz	-	780	1100	pF
	Q2			-	2200	2900	
Output capacitance	Q1	C_{oss}		-	390	520	
	Q2			-	1300	1700	
Reverse transfer capacitance	Q1	C_{rss}		-	38	-	
	Q2			-	71	-	
Turn-on delay time	Q1	$t_{d(on)}$	V_{IN}=12 V, V_{DRV}=5 V, F_{SW}=500 KHz, I_{OUT}=20 A [5]	-	4.3	-	ns
	Q2			-	3.6	-	
Rise time	Q1	t_r		-	4.7	-	
	Q2			-	2.8	-	
Turn-off delay time	Q1	$t_{d(off)}$		-	4.3	-	
	Q2			-	5.7	-	
Fall time	Q1	t_f		-	1.4	-	
	Q2			-	1.7	-	
Gate Charge Characteristics							
Gate to source charge	Q1	Q_{gs}	V_{DD}=12 V, I_D=20 A, V_{GS}=0 to 4.5 V	-	2.0		nC
Gate to drain charge		Q_{gd}		-	1.4	-	
Gate charge total		Q_g		-	5.6	8.4	
Gate plateau voltage		$V_{plateau}$		-	2.6	-	V
Gate to source charge	Q2	Q_{gs}		-	5.2	-	nC
Gate to drain charge		Q_{gd}		-	3.1	-	
Gate charge total		Q_g		-	15	22	
Gate plateau voltage		$V_{plateau}$		-	2.3	-	V
Output charge	Q1	Q_{oss}	V_{DD}=12 V, V_{GS}=0 V	-	8	-	nC
	Q2			-	27	-	

[3] 8 Layers copper 70µm thickness. PCB in still air

[4] Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm^2 (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

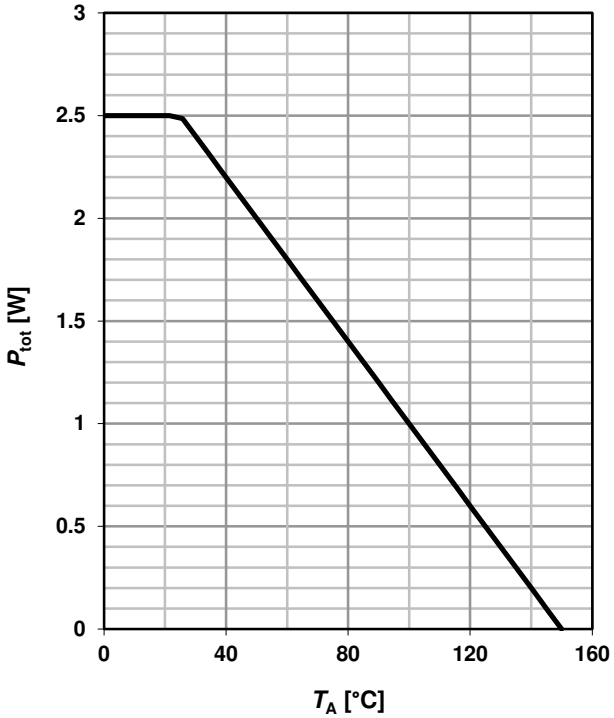
Parameter		Symbol	Conditions	Values			Unit
				min.	typ.	max.	
Reverse Diode							
Diode continuous forward current	Q1	I_S	T_C=25 °C	-	-	29	A
	Q2			-	-	50	
Diode pulse current	Q1	$I_{S,pulse}$		-	-	160	
	Q2			-	-	160	
Diode forward voltage	Q1	V_{SD}	V_{GS}=0 V, I_F=20 A, T_j=25 °C	-	0.82	1	V
	Q2		V_{GS}=0 V, I_F=11 A, T_j=25 °C	-	0.52	0.7	
Reverse recovery charge	Q1	Q_{rr}	V_R=12 V, I_F=I_S, di_F/dt=100 A/µs	-	10	-	nC
	Q2						

[5] For more information see application note n° TBD

[6] The device can withstand a pulse of not more than 30 V for a duration of up to 2 ns at a frequency of 600 kHz with maximum buck converter input voltage V_{IN}=16 V

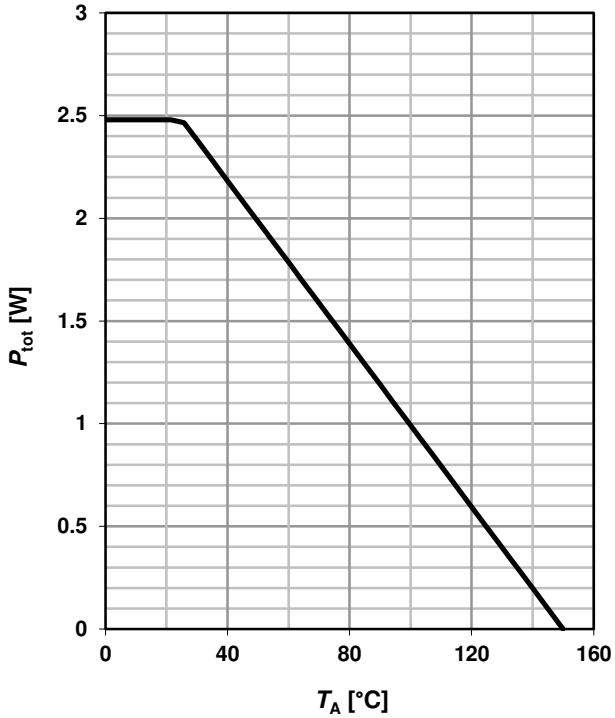
1 Power dissipation (Q1)

$P_{tot}=f(T_A)$[4)]



2 Power dissipation (Q2)

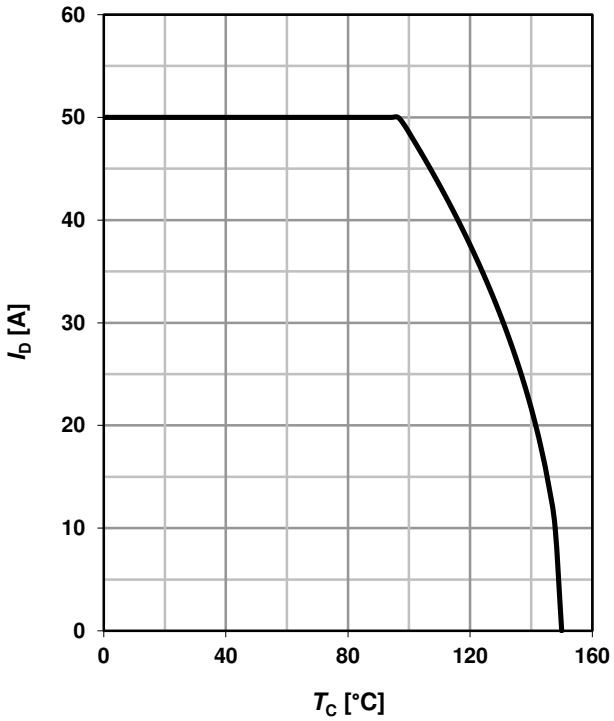
$P_{tot}=f(T_A)$[4)]



3 Drain current (Q1)

$I_D=f(T_C)$

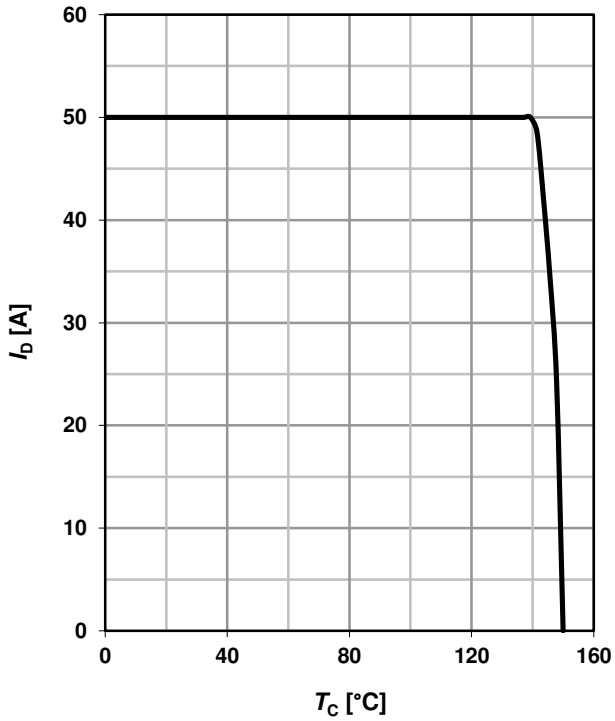
parameter: $V_{GS}\geq 10$ V



4 Drain current (Q2)

$I_D=f(T_C)$

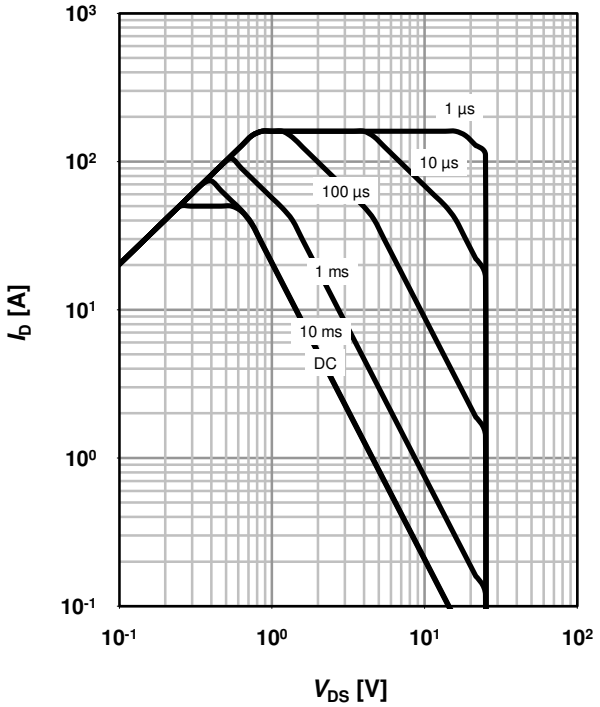
parameter: $V_{GS}\geq 10$ V



5 Safe operating area (Q1)

I_D=f(V_{DS}); T_C=25 °C; D=0

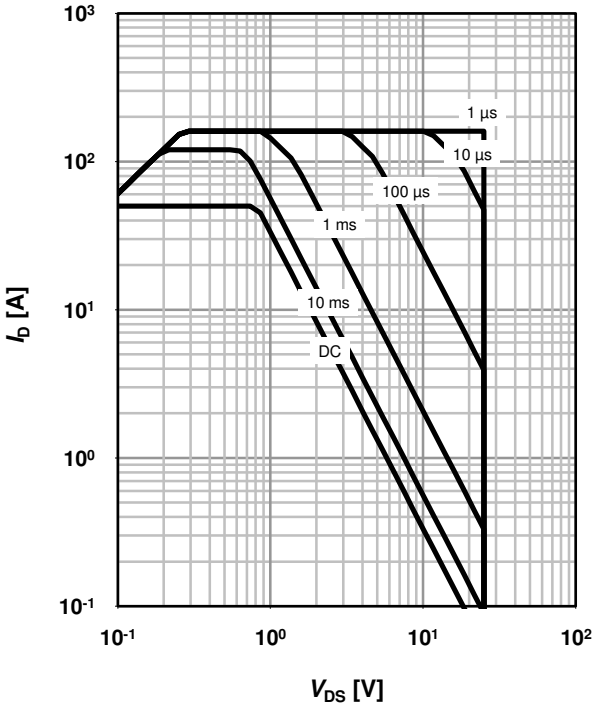
parameter: t_p



6 Safe operating area (Q2)

I_D=f(V_{DS}); T_C=25 °C; D=0

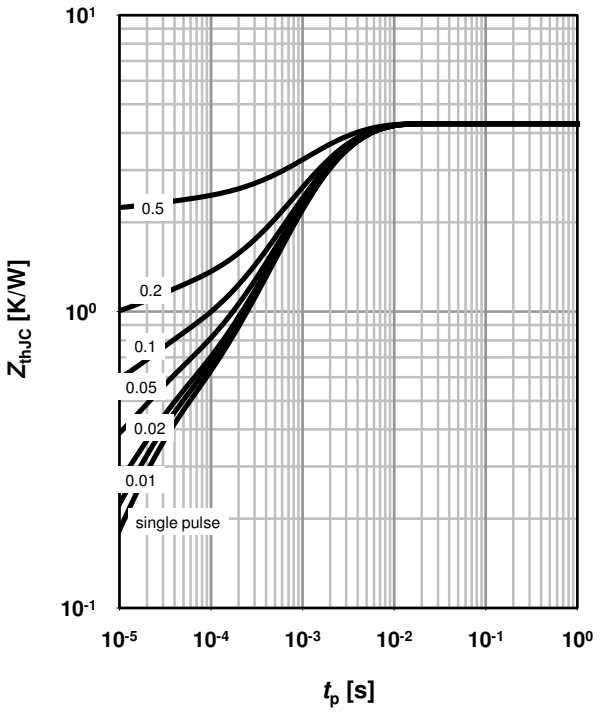
parameter: t_p



7 Max. transient thermal impedance (Q1)

Z_{thJC}=f(t_p)

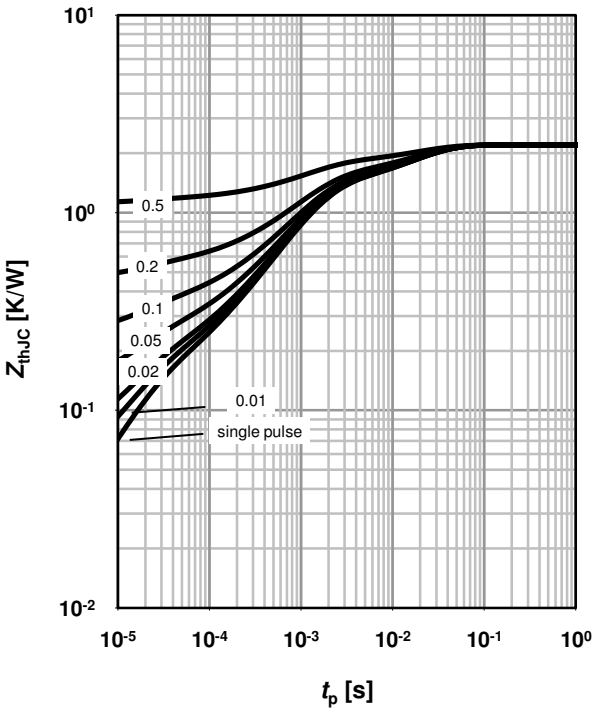
parameter: D=t_p/T



8 Max. transient thermal impedance (Q2)

Z_{thJC}=f(t_p)

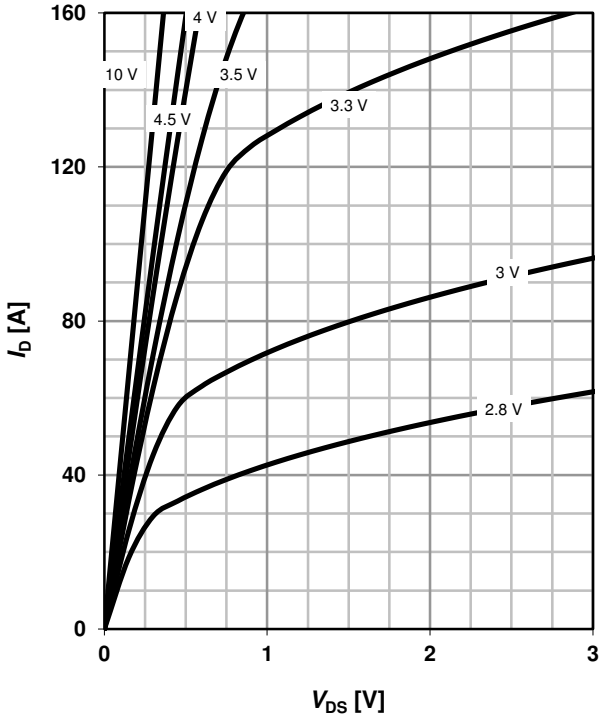
parameter: D=t_p/T



9 Typ. output characteristics (Q1)

I_D=f(V_{DS}); T_j=25 °C

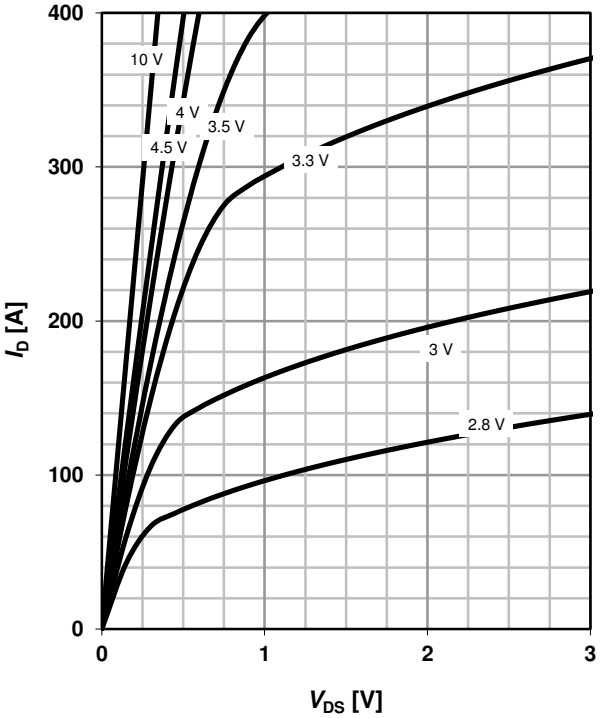
parameter: V_{GS}



10 Typ. output characteristics (Q2)

I_D=f(V_{DS}); T_j=25 °C

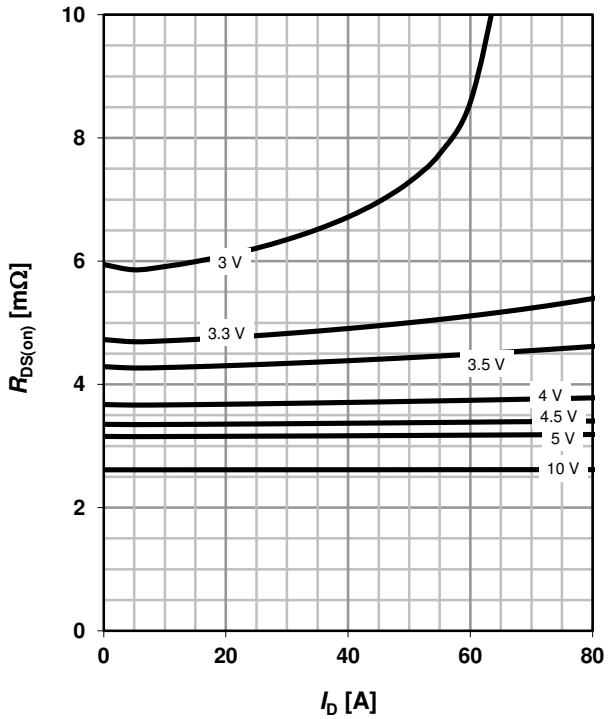
parameter: V_{GS}



11 Typ. drain-source on resistance (Q1)

$R_{DS(on)}$=f(I_D); T_j=25 °C

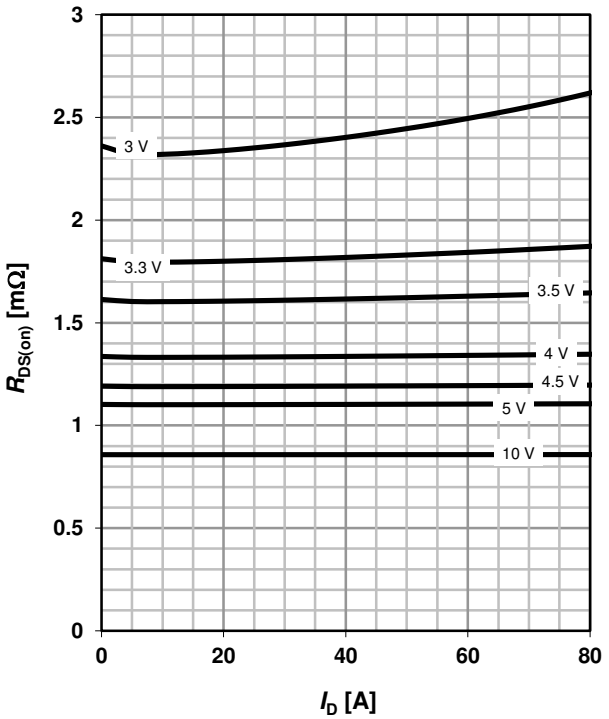
parameter: V_{GS}



12 Typ. drain-source on resistance (Q2)

$R_{DS(on)}$=f(I_D); T_j=25 °C

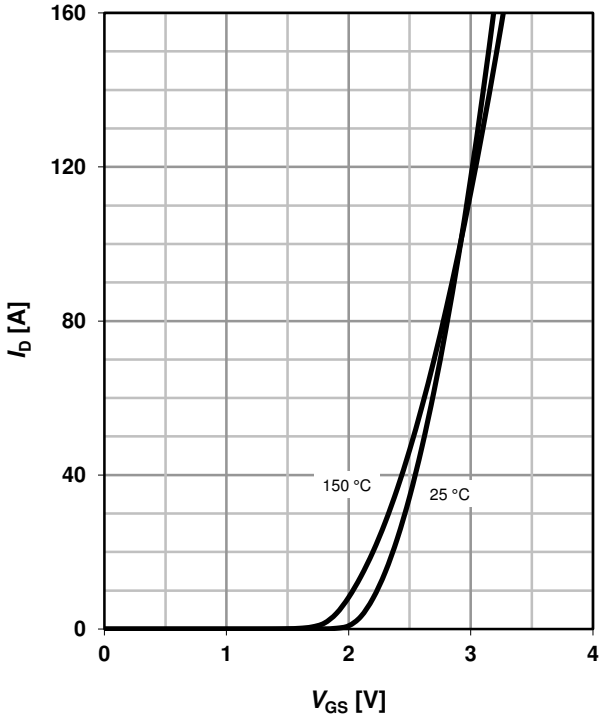
parameter: V_{GS}



13 Typ. transfer characteristics (Q1)

$I_D=f(V_{GS})$; $|V_{DS}|>2 | I_D| R_{DS(on)max}$

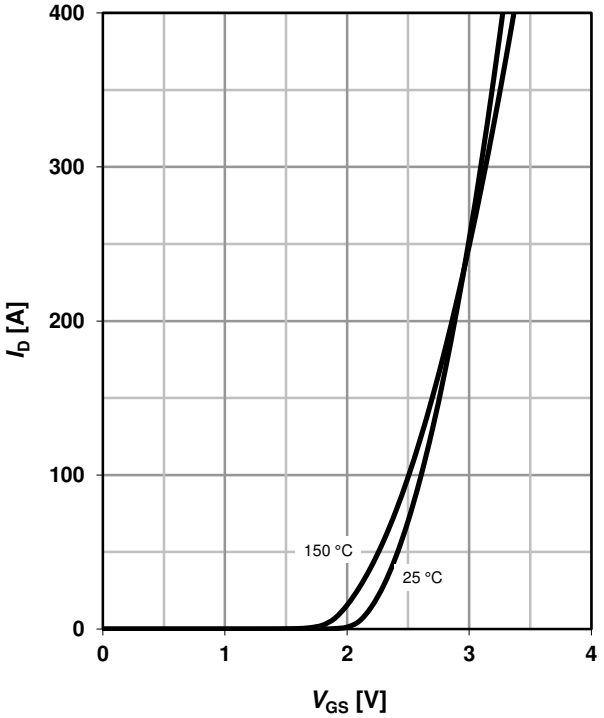
parameter: T_j



14 Typ. transfer characteristics (Q2)

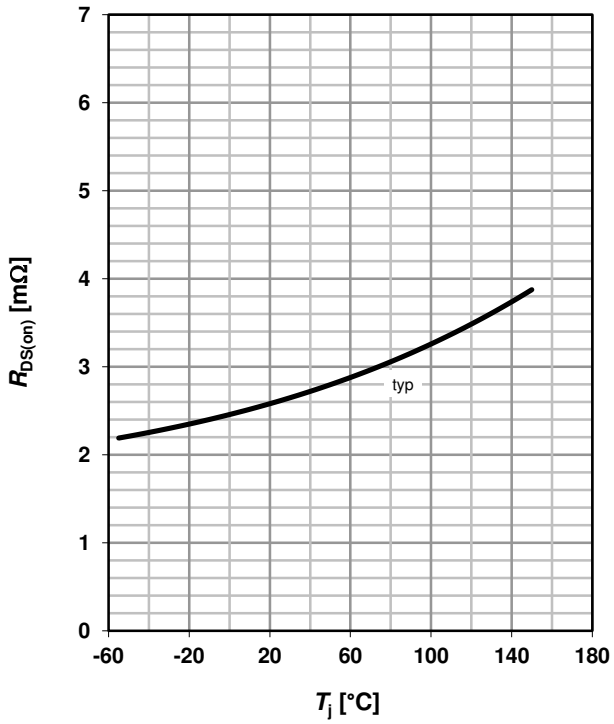
$I_D=f(V_{GS})$; $|V_{DS}|>2 | I_D| R_{DS(on)max}$

parameter: T_j



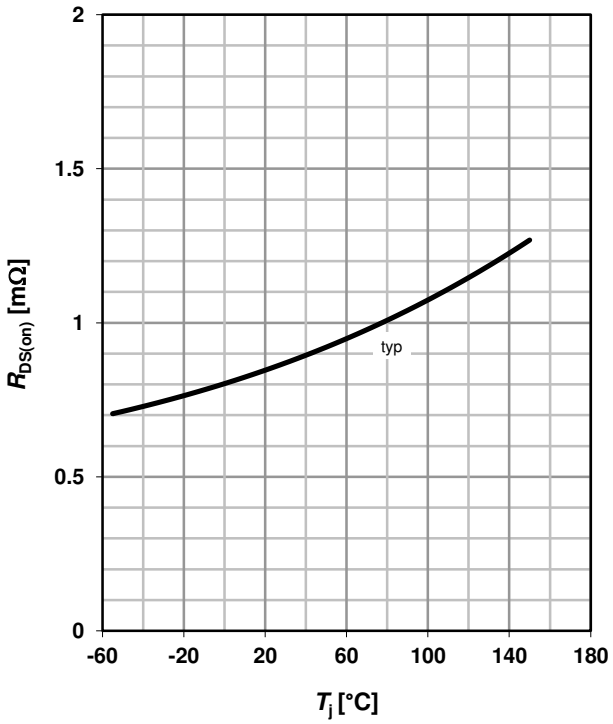
15 Drain-source on-state resistance (Q1)

$R_{DS(on)}=f(T_j)$; I_D=20 A; V_{GS}=10 V



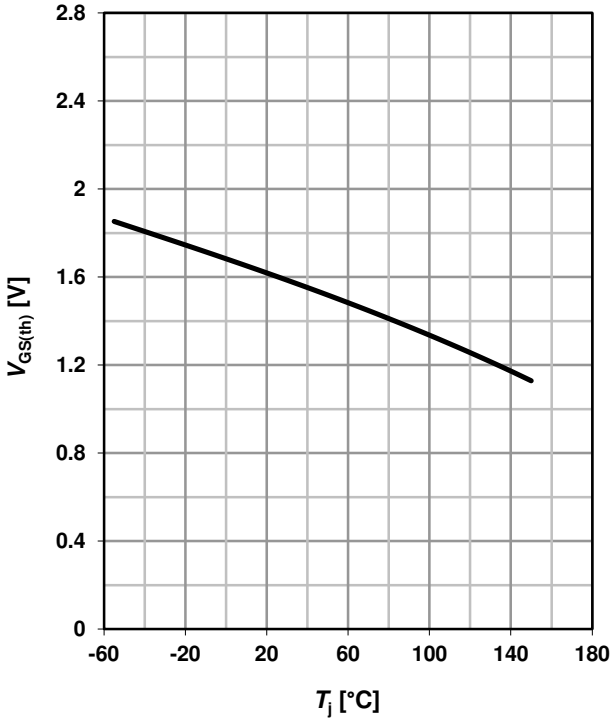
16 Drain-source on-state resistance (Q2)

$R_{DS(on)}=f(T_j)$; I_D=20 A; V_{GS}=10 V



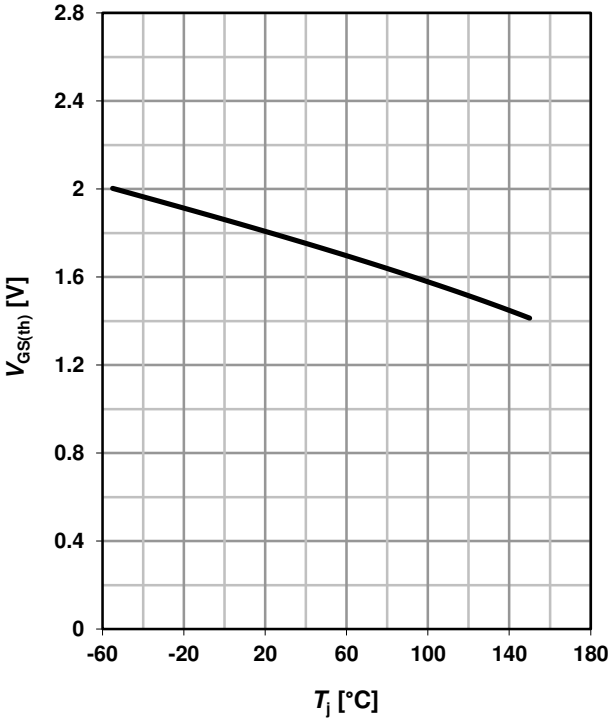
17 Typ. gate threshold voltage (Q1)

$V_{GS(th)}=f(T_j)$; $V_{GS}=V_{DS}$; $I_D=250$ µA



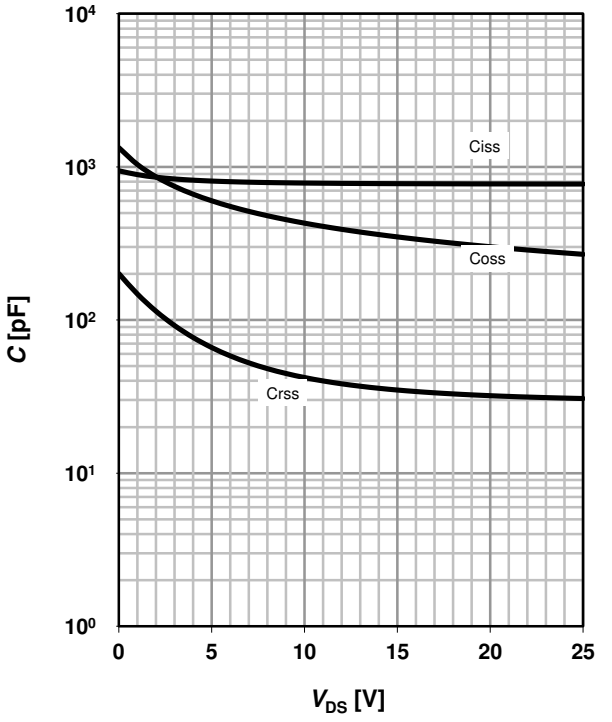
18 Typ. gate threshold voltage (Q2)

$V_{GS(th)}=f(T_j)$; $V_{GS}=V_{DS}$; $I_D=10$ mA



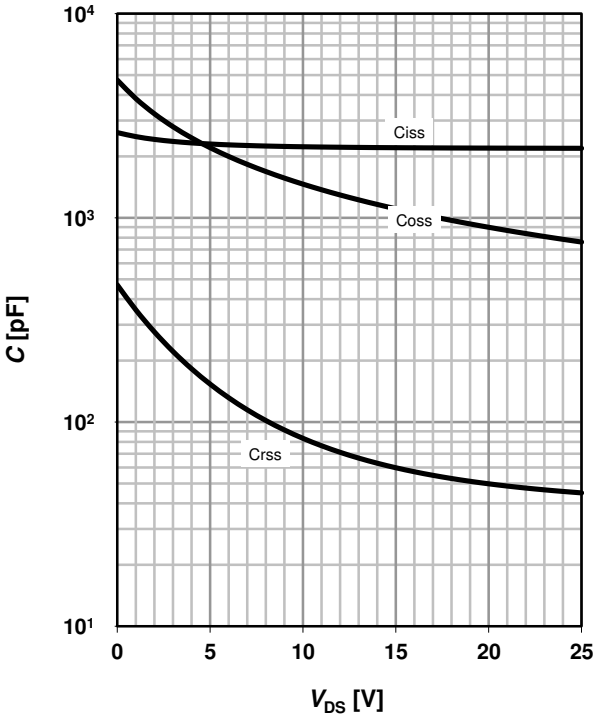
19 Typ. capacitances (Q1)

$C=f(V_{DS})$; $V_{GS}=0$ V; $f=1$ MHz



20 Typ. capacitances (Q2)

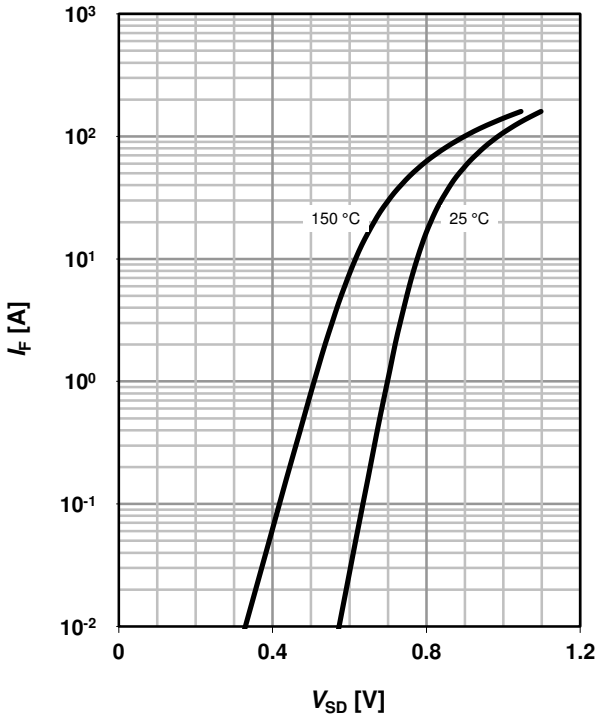
$C=f(V_{DS})$; $V_{GS}=0$ V; $f=1$ MHz



21 Forward characteristics of reverse diode (Q1)

$I_F=f(V_{SD})$

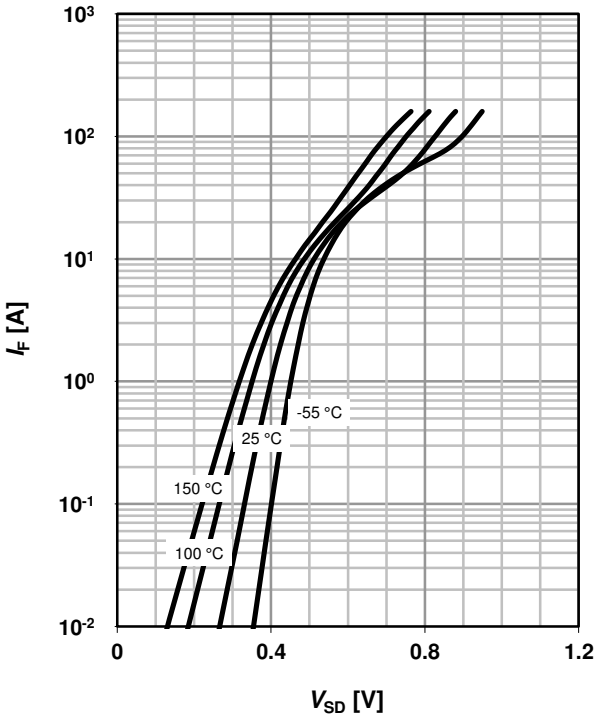
parameter: T_j



22 Forward characteristics of reverse diode (Q2)

$I_F=f(V_{SD})$

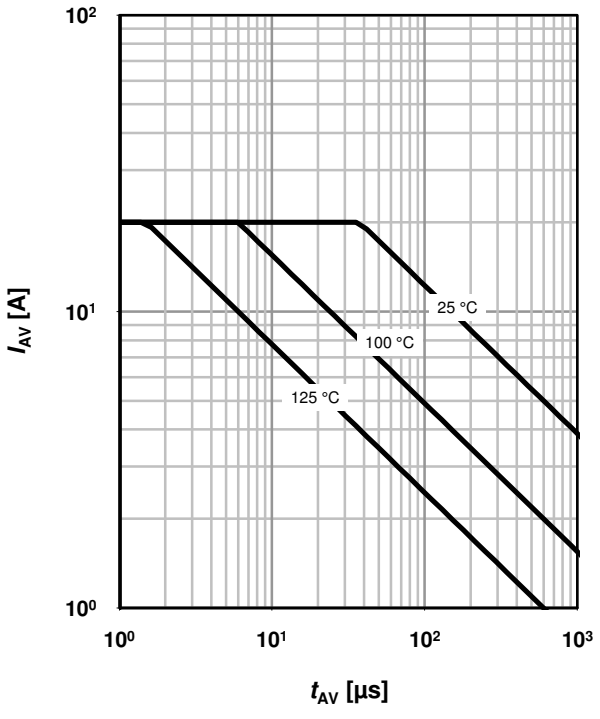
parameter: T_j



23 Avalanche characteristics (Q1)

$I_{AS}=f(t_{AV})$; $R_{GS}=25\ \Omega$

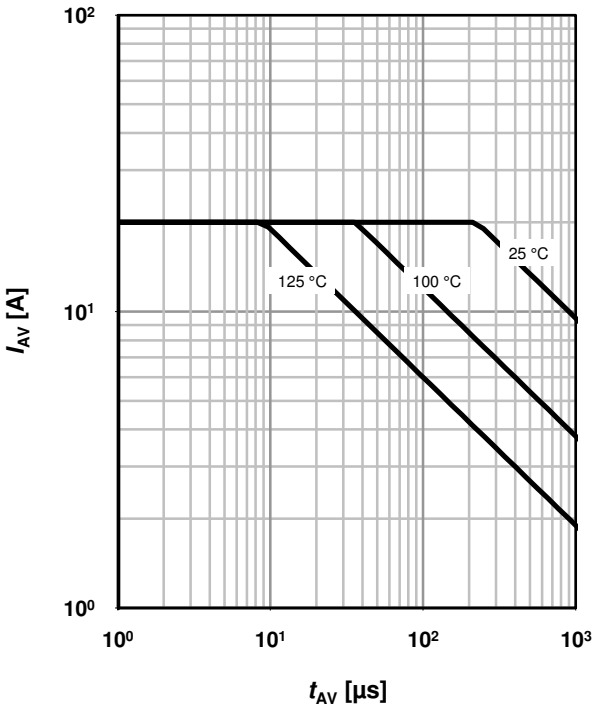
parameter: $T_{j(start)}$



24 Avalanche characteristics (Q2)

$I_{AS}=f(t_{AV})$; $R_{GS}=25\ \Omega$

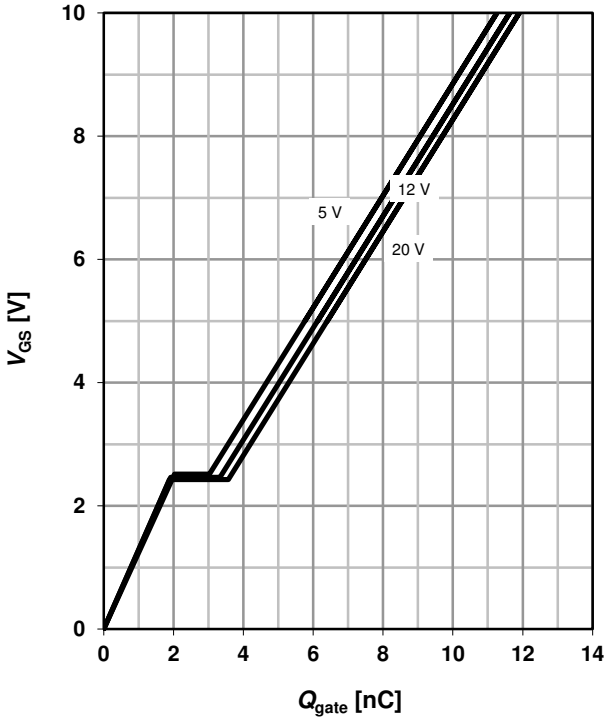
parameter: $T_{j(start)}$



25 Typ. gate charge (Q1)

V_{GS}=f(Q_{gate}); I_D=20 A pulsed

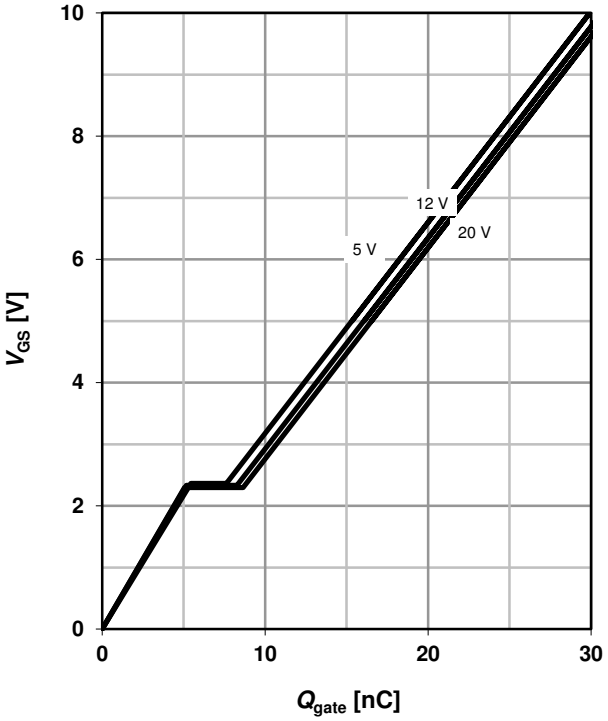
parameter: V_{DD}



26 Typ. gate charge (Q2)

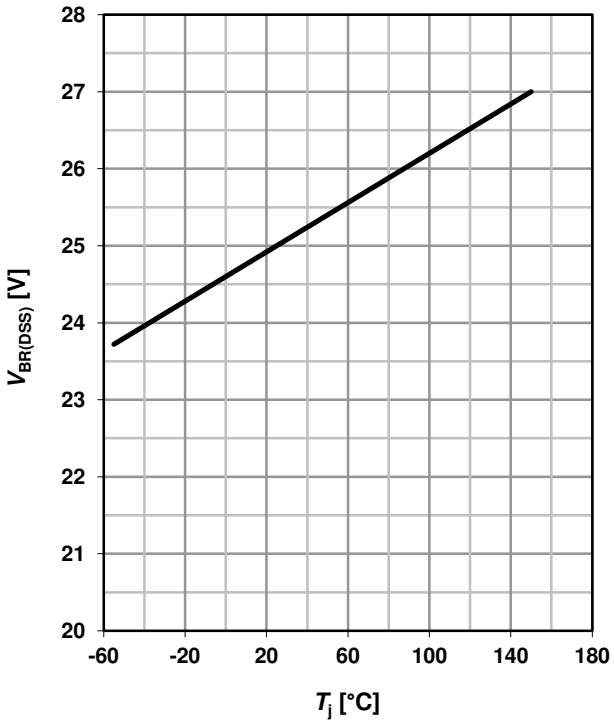
V_{GS}=f(Q_{gate}); I_D=20 A pulsed

parameter: V_{DD}



27 Drain-source breakdown voltage (Q1)

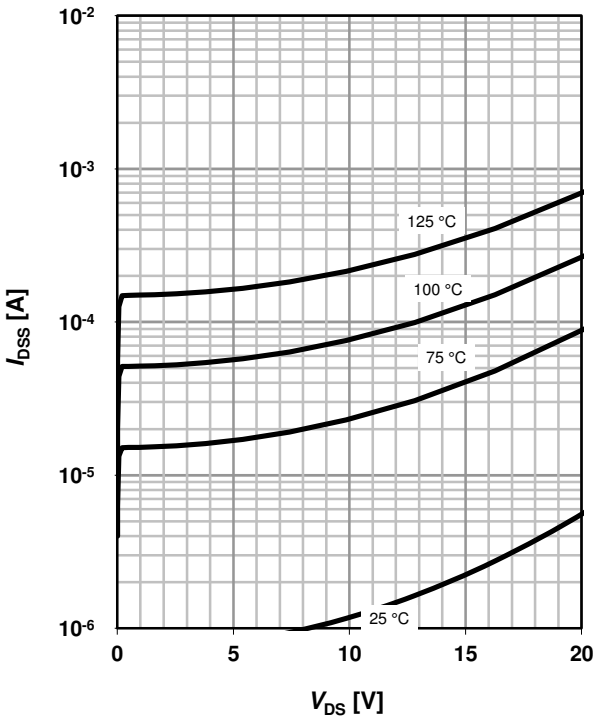
$V_{BR(DSS)}$=f(T_j); I_D=1 mA



28 Typ. drain-source leakage current (Q2)

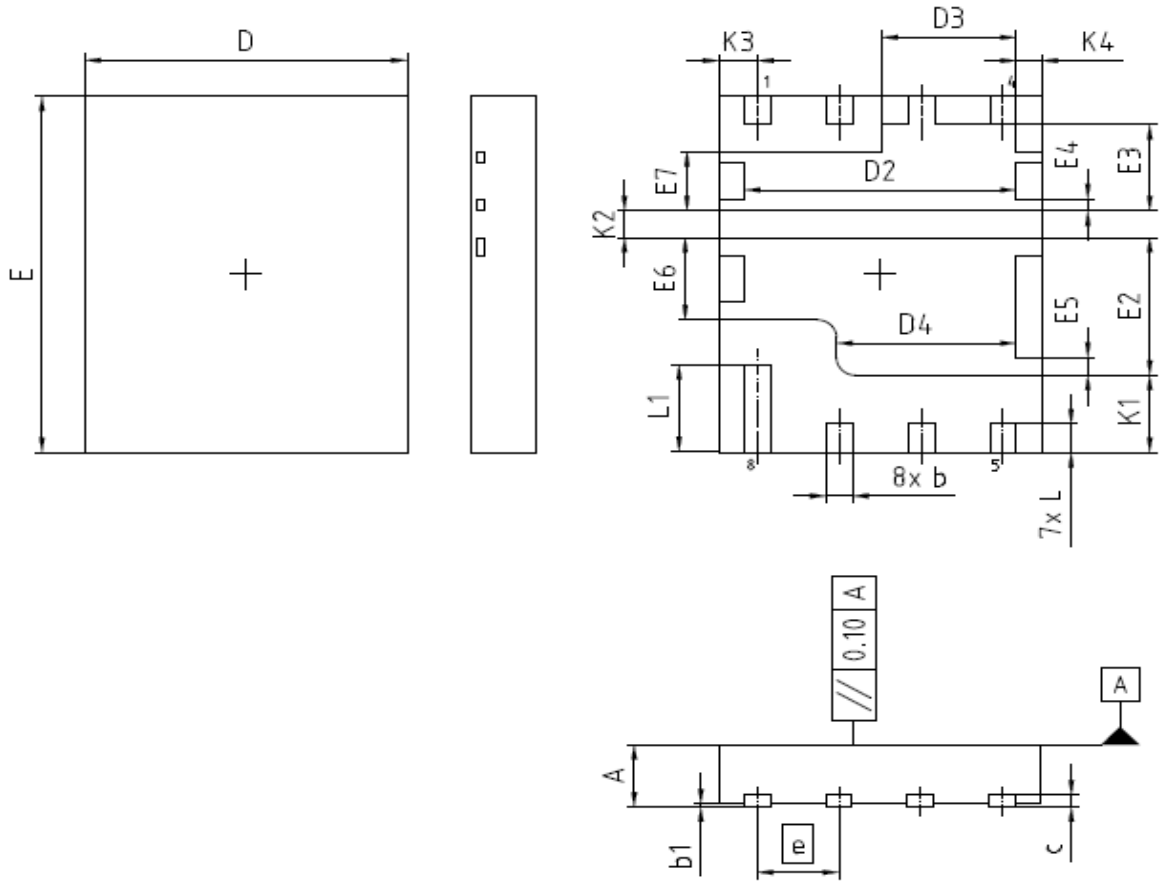
I_{DSS}=f(V_{DS}); V_{GS}=0 V

parameter: T_j

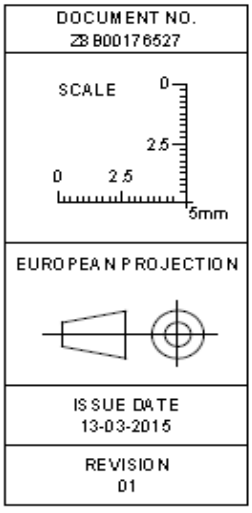


Package Outline

PG-TISON8-4

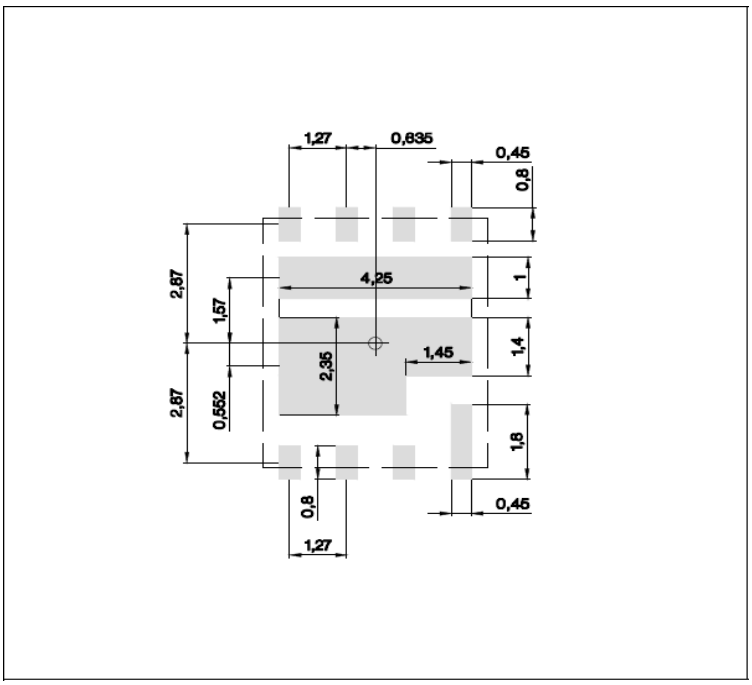


DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.90	1.15	0.035	0.045
b	0.31	0.51	0.012	0.020
b1	0.00	0.05	0.000	0.002
c	0.10	0.30	0.004	0.012
D	4.90	5.10	0.193	0.201
D2	4.12	4.32	0.162	0.170
D3	1.99	2.19	0.078	0.086
D4	2.69	2.89	0.106	0.114
E	5.90	6.10	0.232	0.240
E2	2.22	2.42	0.087	0.095
E3	1.35	1.55	0.053	0.061
E4	0.10	0.30	0.004	0.012
E5	0.20	0.40	0.008	0.016
E6	1.29	1.49	0.051	0.059
E7	0.90	1.10	0.035	0.043
e	1.27 (BSC)		0.05 (BSC)	
N	8		8	
L	0.38	0.58	0.015	0.023
L1	1.38	1.58	0.054	0.062
K1	1.20	1.40	0.047	0.055
K2	0.35	0.55	0.014	0.022
K3	0.50	0.70	0.020	0.028
K4	0.29	0.49	0.011	0.019

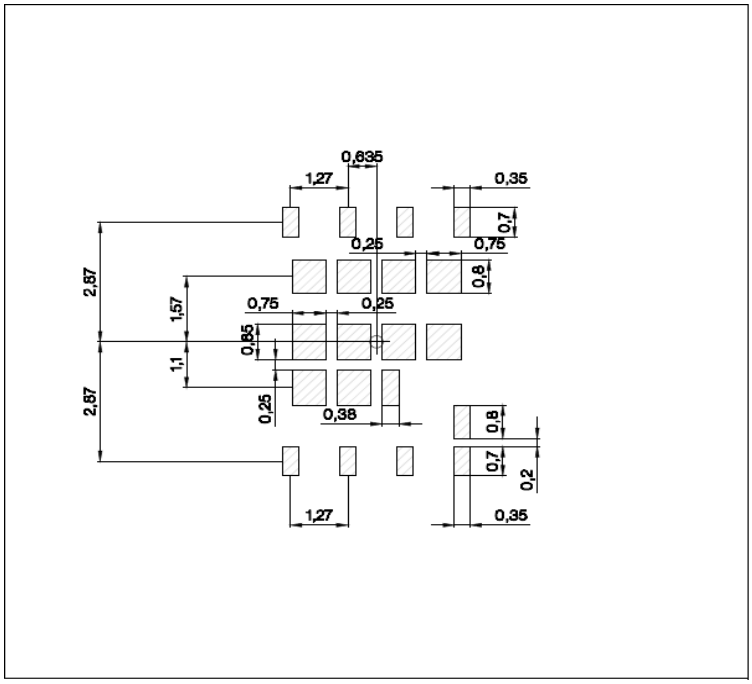


Boardpads & Apertures

PG-TISON8-4



copper



stencil apertures

All the dimensions in mm

Revision History

BSG0813NDI

Revision: 2016-03-24, Rev. 2.1

Previous Revision		
Revision	Date	Subjects (major changes since last revision)
2.0	2015-03-17	Release of final version
2.1	2016-03-24	Update package drawing

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